



44 FARRAND STREET
BLOOMFIELD, NJ 07003
(973) 748-5089

NTE2987
Logic Level MOSFET
N-Channel, Enhancement Mode
High Speed Switch

Features:

- Avalanche Rugged Technology
- Logic Level Gate Drive
- $R_{DS(on)} = 0.09\Omega$ Typ. at $V_{GS} = 5V$
- $+175^{\circ}C$ Operating Temperature
- Fast Switching
- Low Gate Charge
- High Current Capability

Absolute Maximum Ratings:

Drain Current, I_D Continuous	
$T_C = +25^{\circ}C$	20A
$T_C = +100^{\circ}C$	14A
Pulsed (Note 1)	80A
Total Power Dissipation ($T_C = +25^{\circ}C$), P_D	105W
Derate Above $25^{\circ}C$	$0.7W/^{\circ}C$
Gate-Source Voltage, V_{GS}	$\pm 15V$
Avalanche Current, Repetitive or Non-Repetitive (Note 2), I_{AR}	20A
Single Pulsed Avalanche Energy (Note 3), E_{AS}	120mJ
Repetitive Avalanche Energy (Note 2), E_{AR}	30mJ
Avalanche Current, Repetitive or Non-Repetitive (Note 4), I_{AR}	14A
Drain-Source Voltage ($V_{GS} = 0$), V_{DS}	100V
Drain-Gate Voltage ($R_{GS} = 20k\Omega$), V_{DGR}	100V
Operating Junction Temperature, T_J	$+175^{\circ}C$
Storage Temperature Range, T_{stg}	-65° to $+175^{\circ}C$
Maximum Lead Temperature (During Soldering, 1.6mm from case, 10sec), T_L	$+300^{\circ}C$
Thermal Resistance:	
Maximum Junction-to-Case, R_{thJC}	$1.43^{\circ}C/W$
Typical Case-to-Sink (Mounting surface flat, smooth, and greased), R_{thCS}	$0.5^{\circ}C/W$
Maximum Junction-to-Ambient (Free Air Operation), R_{thJA}	$62.5^{\circ}C/W$

Note 1. Pulse width limited by safe operating area.

Note 2. Pulse width limited by T_J max, Duty Cycle < 1%.

Note 3. $V_{DD} = 25V$, $I_D = I_{AR}$, Starting $T_J = +175^{\circ}C$.

Note 4. $T_C = +100^{\circ}C$, Pulse width limited by T_J max, Duty Cycle < 1%.

Electrical Characteristics: ($T_C = +25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
OFF						
Drain–Source Breakdown Voltage	BV_{DSS}	$V_{\text{GS}} = 0\text{V}, I_D = 250\mu\text{A}$	100	—	—	V
Drain-to-Source Leakage Current	I_{DSS}	$V_{\text{DS}} = 100\text{V}, V_{\text{GS}} = 0$	—	—	1	μA
		$V_{\text{DS}} = 80\text{V}, V_{\text{GS}} = 0\text{V}, T_C = +150^\circ\text{C}$	—	—	10	μA
Gate–Source Leakage Forward	I_{GSS}	$V_{\text{GS}} = 15\text{V}$	—	—	100	nA
Gate–Source Leakage Reverse	I_{GSS}	$V_{\text{GS}} = -15\text{V}$	—	—	-100	nA
ON (Note 5)						
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}} = V_{\text{GS}}, I_D = 250\mu\text{A}$	1.0	1.6	2.5	V
Static Drain–Source ON Resistance	$R_{\text{DS}(\text{on})}$	$V_{\text{GS}} = 5\text{V}, I_D = 10\text{A}$	—	0.09	0.12	Ω
On–State Drain Current	$I_{\text{D}(\text{on})}$	$V_{\text{DS}} > I_{\text{D}(\text{on})} \times R_{\text{DS}(\text{on})\text{max}}, V_{\text{GS}} = 10\text{V}$	20	—	—	A
Dynamic						
Forward Transconductance	g_{fs}	$V_{\text{DS}} > I_{\text{D}(\text{on})} \times R_{\text{DS}(\text{on})\text{max}}, I_D = 10\text{A},$ Note 5	10	16	—	mhos
Input Capacitance	C_{iss}	$V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = 25\text{V}, f = 1\text{MHz}$	—	1200	1500	pF
Output Capacitance	C_{oss}		—	250	350	pF
Reverse Transfer Capacitance	C_{rss}		—	60	90	pF
Switching						
Total Gate Charge	Q_g	$V_{\text{GS}} = 5\text{V}, I_D = 20\text{A}, V_{\text{DD}} = 80\text{V}$	—	22	30	nC
Gate–Source Charge	Q_{gs}		—	6	—	nC
Gate–Drain (“Miller”) Charge	Q_{gd}		—	12	—	nC
Turn–On Delay Time	$t_{\text{d}(\text{on})}$	$V_{\text{DD}} = 30\text{V}, I_D = 10\text{A}, R_G = 50\Omega,$ $V_{\text{GS}} = 5\text{V}$	—	50	70	ns
Rise Time	t_r		—	140	200	ns
Turn–Off Delay Time	$t_{\text{d}(\text{off})}$		—	80	110	ns
Fall Time	t_f	$V_{\text{DD}} = 80\text{V}, I_D = 20\text{A}, R_G = 50\Omega,$ $V_{\text{GS}} = 5\text{V}$	—	80	110	ns
Source–Drain Diode Ratings and Characteristics						
Continuous Source Current	I_S	(Body Diode)	—	—	20	A
Pulse Source Current	I_{SM}	(Body Diode) Note 1	—	—	80	A
Diode Forward Voltage	V_{SD}	$I_{\text{SD}} = 20\text{A}, V_{\text{GS}} = 0\text{V}$, Note 5	—	—	1.5	V
Reverse Recovery Time	t_{rr}	$T_J = +150^\circ\text{C}, V_{\text{DD}} = 50\text{V}, I_{\text{SD}} = 20\text{A},$ $dI/dt = 100\text{A}/\mu\text{s}$	—	130	—	ns
Reverse Recovery Charge	Q_{rr}		—	0.4	—	μC
Reverse Recovery Current	I_{RRM}		—	6	—	A

Note 1. Pulse width limited by safe operating area.

Note 5. Pulse Test: Pulse Width = 300 μs , Duty Cycle = 1.5%.

